Search Notes

Application/Control	No
10/731.503	

Applicant(s)/Patent under Reexamination

Examiner Steven J. Fulk WU, SHYE-LIN Art Unit 2891

SEARCHED				
Class	Subclass	Date	Examiner	
257	471	2/2/2006	SJF	
257	473	2/2/2006	SJF	
257	475	2/2/2006	SJF	
257	483	2/2/2006	SJF	
257	484	2/2/2006	SJF	
257	485	2/2/2006	SJF	
438	534	2/2/2006	SJF	
438	575	2/2/2006	SJF	
438	576	2/2/2006	SJF	

INTERFERENCE SEARCHED				
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PG Pubs	Claims	2/2/2006	SJF	

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438/1+; 257/1+ (text search only - see search history printout)	2/2/2006	SJF
IEEE Xplore - see search history printout	2/2/2006	SJF
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